Test Equipment Solutions Datasheet

Test Equipment Solutions Ltd specialise in the second user sale, rental and distribution of quality test & measurement (T&M) equipment. We stock all major equipment types such as spectrum analyzers, signal generators, oscilloscopes, power meters, logic analysers etc from all the major suppliers such as Agilent, Tektronix, Anritsu and Rohde & Schwarz.

We are focused at the professional end of the marketplace, primarily working with customers for whom high performance, quality and service are key, whilst realising the cost savings that second user equipment offers. As such, we fully test & refurbish equipment in our in-house, traceable Lab. Items are supplied with manuals, accessories and typically a full no-quibble 2 year warranty. Our staff have extensive backgrounds in T&M, totalling over 150 years of combined experience, which enables us to deliver industry-leading service and support. We endeavour to be customer focused in every way right down to the detail, such as offering free delivery on sales, covering the cost of warranty returns BOTH ways (plus supplying a loan unit, if available) and supplying a free business tool with every order.

As well as the headline benefit of cost saving, second user offers shorter lead times, higher reliability and multivendor solutions. Rental, of course, is ideal for shorter term needs and offers fast delivery, flexibility, try-before-you-buy, zero capital expenditure, lower risk and off balance sheet accounting. Both second user and rental improve the key business measure of Return On Capital Employed.

We are based near Heathrow Airport in the UK from where we supply test equipment worldwide. Our facility incorporates Sales, Support, Admin, Logistics and our own in-house Lab.

All products supplied by Test Equipment Solutions include:

- No-quibble parts & labour warranty (we provide transport for UK mainland addresses).
- Free loan equipment during warranty repair, if available.
- Full electrical, mechanical and safety refurbishment in our in-house Lab.
- Certificate of Conformance (calibration available on request).
- Manuals and accessories required for normal operation.
- Free insured delivery to your UK mainland address (sales).
- Support from our team of seasoned Test & Measurement engineers.
- ISO9001 quality assurance.

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Agilent E8241A/44A/51A/54A PSG Family Performance Signal Generator

Data Sheet



	CW only PSG-L Series	Analog PSG-A Series
250 kHz to 20 GHz	E8241A	E8251A
250 kHz to 40 GHz	E8244A	E8254A

All specifications and characteristics apply over a 0 to 55°C range (unless otherwise stated) and apply after a 45 minute warm-up time. Supplemental characteristics, denoted as typical or nominal, provide additional (non-warranted) information.

Definitions

Specifications (spec): represent warranted performance.

Typical (typ): performance is not warranted. It applies at 25°C. 80% of all products meet typical performance.

Nominal (nom): values are not warranted. They represent the value of a parameter that is most likely to occur; the expected or mean value. They are included to facilitate the application of the product.

Standard (std): No options are included when referring to the signal generator unless noted otherwise.



Specifications

L and A Series

Frequency					
Range ¹					
Frequency Range	PSG-L Series	PSG-A Series			
250 kHz to 20 GHz	E8241A	E8251A			
250 kHz to 40 GHz	E8244A	E8254A			
Resolution		0.01 Hz			
Accuracy		Calibration = aging rate ± line voltage effects	± temperature effects		
Switching speed (typi	cal) ²				
Analog modulation		< 15 ms			
Modulation off		< 15 ms			
Phase offset		Adjustable in nominal ().1° increments.		
Frequency bands					
Band	· La	Frequency range	N #		
1		250 kHz to 250 MHz	1/8		
2		> 250 to 500 MHz	1/16		
3		> 500 MHz to 1 GHz	1/8		
4		⊳ 1 to 2 GHz	1/4		
5		> 2 to 3.2 GHz	1/2		
6 Leoi viii		> 3.2 to 10 GHz	1		
7	Mente	> 10 to 20 GHz	2		
Falignent estation		> 20 to 40 GHz	4		
Mal	Ed ny				
Internal timebase refe	rence oscillator				
9	31 710.0	Standard	Option UNJ		
Aging rate	lenti	$< \pm 1 \times 10^{-7}$ /year or $< \pm 4.5 \times 10^{-9}$ /day	$< \pm 3 \times 10^{-8}$ /year or $< \pm 2.5 \times 10^{-10}$ /day		
ceco, wiph		after 45 days	after 24 hours		
Temperature effects (t	ypical)	< ±5 x 10 ⁻⁸ 0 to 55°C	< ±4.5 x 10 ⁻⁹ 0 to 55°C		
Line voltage effects (t	ypical)	< ±2 x 10 ⁻⁹ for +5% –10% change	< ±2 x 10 ⁻¹⁰ for ±10% change		
External reference fre	quency	1, 2, 2.5, 5, 10 MHz (within 1 ppm)	10 MHz only (within 1 ppm)		
Reference output					
Frequency		10 MHz	10 MHz		
Amplitude		> +4 dBm typical into 5	> +4 dBm typical into 50Ω load		
External reference inp	ut				
Amplitude		> -3 dBm			
Opt UNJ	5 dBm ±5 dB ³				
Input impedance		50Ω⇔ nominal			
Digital sweep					
Operating modes		Step sweep of frequence (Start to stop)	Step sweep of frequency or amplitude or both (Start to stop)		
		List sweep of frequence	y or amplitude or both		

(Arbitrary list)

¹ Useable to 100 kHz

 $^{^2}$ To within 0.1 ppm of final frequency above 250 MHz or within 100 Hz below 250 MHz $\,$

 $^{^3}$ To optimize phase noise 5 dBm \pm 2 dB

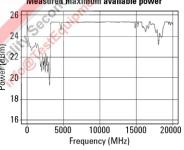
Sweep range	
Frequency sweep	Within instrument frequency range
Amplitude sweep	Within attenuator hold range
Dwell time	1 ms to 60 s
Frequency settling time	28 ms typical
Amplitude settling time	10 ms typical
Number of points	2 to 1601
Triggering	Auto, external, single, or GPIB

Output

Power ⁴	/dDm/
Power:	(upill)
	(,

()					
Frequency range	Standard	Option 1EA			
20 GHz Models					
250 kHz to 3.2 GHz	-20 to +13	-20 to +16			
> 3.2 to 20 GHz	-20 to +13	-20 to +20			
40 GHz Models					
250 kHz to 3.2 GHz	-20 to +9	-20 to +15			
> 3.2 to 20 GHz	-20 to +9	-20 to +18			
> 20 to 40 GHz	-20 to +9	-20 to +14			
20 GHz Models with option 1E1					
250 kHz to 3.2 GHz	-135 to +11	-135 to +15			
> 3.2 to 20 GHz	135 to +11	-135 to +18			
> 3.2 to 20 GHz 40GHz Models with option 1E1 250 kHz to 3.2 GHz					
250 kHz to 3.2 GHz	-135 to +7	-135 to +14			
> 3.2 to 20 GHz	-135 to +7	-135 to +16			
> 20 to 40 GHz	-135 to +7	-135 to +12			
Option 1E1 step attenuator	0 dB and 5 to 115 dB in	10 dB steps			

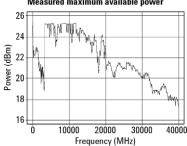
20 GHz Models with option 1EA Measured maximum available power



±0.8

±1.0

40 GHz Models with option 1EA Measured maximum available power



±1.2

±1.3

Attenuator hold range

2 GHz to 20 GHz

> 20 to 40 GHz

(Same as max power sweep range)

(oumo do max porror	orroop range,			
Minimum		From –20 dBm to maximum specified output power. Can be offset using Option 1E1 attenuator.		
Amplitude switching	speed ⁵			
CW or analog modulation		< 25 ms, typical		
When using power s	earch	< 25 ms, typical		
CW level accuracy ⁶ (dB)			
Frequency	> +10 dBm	+10 to –10 dBm	–10 to –20 dBm	
250 kHz to 2 GHz	+0.6	+0.6	+1 4	

±0.8

±0.9

- Maximum power specification is warranted from 15 to 35°C, and is typical from 0 to 15°C. Maximum power over the 35 to 55°C range typically degrades less than 2 dB.
- ⁵ To within 0.1 dB of final amplitude within one attenuator range
- ⁶ Specifications apply over the 15 to 35°C temperature range. Degradation outside this range, for power levels > -10 dBm, is typically < 0.3 dB.</p>

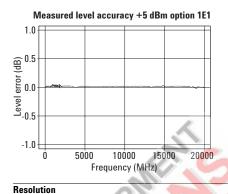
For instruments with type-N connectors (Option 1ED), specifications are degraded typically 0.2 dB above 18 GHz.

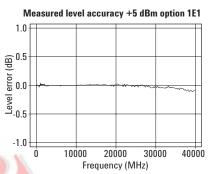
CW level accuracy with option 1E1⁷ (dB)

Frequency	> +10 dBm	+10 to -10 dBm	–10 to –70 dBm	-70 to -90 dBm	−90 to −110 dBm
250 kHz to 2 GHz	±0.6	±0.6	±0.7	±0.8	±1.4
> 2 to 20 GHz	±0.8	±0.8	±0.9	±1.0	±1.7
> 20 to 40 GHz	±1.0	±0.9	±1.0	±2.0	

20 GHz level accuracy

40 GHz level accuracy





-0.2 mV to -0.5 V, nominal (-36 dBm to +4 dBm

using Agilent 33330D/E detector)

(Note: not intended for pulsed operation)

Typically 10 kHz

1/2 Watt nominal

Temperature stability	0.01 dB/°C, typical
-	
User flatness correction	No other
Number of points	2 to 1601 points/table
Number of tables	Up to 10,000, memory limited
Path loss	Arbitrary, within attenuator range
Entry modes	2 to 1601 points/table Up to 10,000, memory limited Arbitrary, within attenuator range Remote power meter ⁸ , remote bus, manual (user edit/view) 50 Ω , nominal
Output impedance	50 Ω , nominal
SWR (internally leveled, typical)	
250 kHz to 2 GHz	< 1.4:1
> 2 GHz to 20 GHz	< 1.6:1
> 20 GHz to 40 GHz	< 1.8:1
Leveling modes	Internal leveling, external detector leveling, millimeter source module, ALC Off

0.01 dB

For instruments with type-N connectors (Option 1ED), specifications are degraded typically 0.2 dB above 18 GHz. Level accuracy is not specified below -110 dBm.

- 8 Compatible with Agilent Technologies EPM Series (E4418B and E4419B) power meters.
- 9 Specifications for harmonics beyond maximum instrument frequencies are typical.

Spectral purity

Range

Bandwidth

External detector leveling

Maximum reverse power

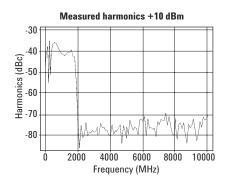
Harmonics⁹ (dBc at +10 dBm or maximum specified output power, whichever is lower)

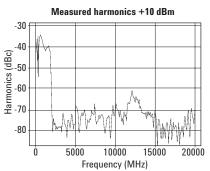
< 1 MHz	-30 dBc typical
1 MHz to 2 GHz	-30 dBc
> 2 GHz to 20 GHz	–55 dBc
> 20 GHz to 40 GHz	-50 dBc typical

⁷ Specifications apply over the 15 to 35°C temperature range, with attenuator lock off (normal operating mode). Degradation outside this range, for ALC power levels > -10 dBm, is typically < 0.3 dB.</p>

20 GHz Measured harmonics

40 GHz Measured harmonics





Sub-harmonics: 10 (dBc at +10 dBm or maximum specified output power, whichever is lower)

250 kHz to 10 GHz

None

> 10 GHz to 20 GHz

< -60 dBc

> 20 GHz to 40 GHz

<-50 dBc

Non-harmonics: (dBc at +10 dBm or maximum specified output power, whichever is lower, for offsets > 3 KHz (>300 Hz with Option UNJ))11

Frequency	Spec	Typical
250 kHz to 250 MHz	< -65	-72 for > 10 kHz offsets
> 250 MHz to 1 GHz	< -80	< -88
> 1 to 2 GHz	< -74	< -82
> 2 to 3.2 GHz	< -68	-76
> 3.2 to 10 GHz	< -62	-70
> 10 to 20 GHz	< -56	-64
> 20 to 40 GHz	< -50	-58

SSB phase noise (CW) Offset from Carrier (dBc/Hz)

Frequency	20 kHz	20 kHz typical
250 kHz to 250 MHz	-130	-134
> 250 to 500 MHz	-136	-140
> 500 MHz to 1 GHz	-130	-134
> 1 to 2 GHz	-124	-128
> 2 to 3.2 GHz	-120	-124
> 3.2 to 10 GHz	-110	-113
> 10 to 20 GHz	-104	-108
> 20 to 40 GHz	-98	-102

¹⁰ Specifications for harmonics beyond maximum instrument frequencies are typical.

¹¹ Performance is typical for spurs at frequencies above the maximum operating frequency of the instrument. Specifications apply for CW mode only. Performance typically is –60 dBc between 200 and 250 MHz.

Option UNJ: Improved SSB phase noise

Offset from carrier (dBc/Hz)

Frequency	100 Hz spec (typ)	1 kHz spec (typ)	10 kHz spec (typ)	100 kHz spec (typ)
250 kHz to 250 MHz	–94 (–115)	-110 (-123)	-128 (-132)	-130 (-133)
> 250 to 500 MHz	-100 (-110)	-124 (-130)	-132 (-136)	-136 (-141)
> 500 MHz to 1 GHz	-94 (-104)	-118 (-126)	-130 (-135)	-130 (-135)
> 1 to 2 GHz	-88 (-98)	-112 (-120)	-124 (-129)	-124 (-129)
> 2 to 3.2 GHz	-84 (-94)	-108 (-116)	-120 (-125)	-120 (-125)
> 3.2 to 10 GHz	−74 (−84)	-98 (-106)	-110 (-115)	-110 (-115)
> 10 to 20 GHz	-68 (-78)	-92 (-100)	-104 (-107)	-104 (-109)
> 20 to 40 GHz	–62 (–72)	-86 (-94)	-98 (-101)	-98 (-103)

Residual FM < N x 6 Hz, typical Option UNJ < N x 4 Hz, typical

(rms, 50 Hz to 15 kHz bandwidth)

Broadband noise (CW mode at +10 dBm output,

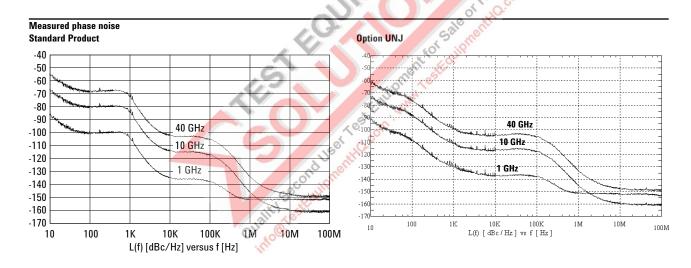
for offsets > 10 MHz)

> 0.25 to 20 GHz

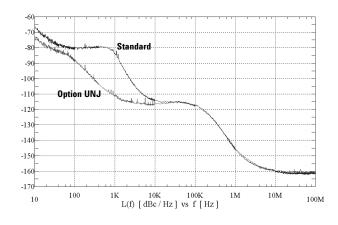
> 20 to 40 GHz

< -148 dBc/Hz typical

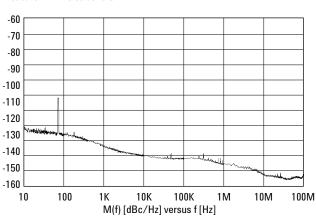
< -141 dBc/Hz typical







Measured AM noise at 10 GHz



Frequency modulat	ion		
Maximum deviation		N x 8 MHz	
Resolution		0.1% of deviation or 1 I	Hz, whichever is greater
Deviation accuracy		< ± 3.5% of FM deviati (1 kHz rate, deviations	
Modulation frequency r	esponse		
Path	Rates (at 100 kHz deviati 1 dB Bandwidth	ion) 3 dB Bandwidth, typic	al
FM 1	dc/20 Hz to 100 kHz	dc/5 Hz to 10 MHz	
FM 2	dc/20 Hz to 100 kHz	dc/5 Hz to 1 MHz	
dc FM ¹² carrier offset		±0.1% of set deviation	+ (N x 8 Hz)
Distortion		< 1% (1 kHz rate, devia	tions < N x 800 kHz)
Sensitivity		±1 Vpeak for indicated	deviation
Paths	IP MEN	modulation. Either path one of the modulation internal1, internal2. Th maximum rate of 1 MH to a deviation less than	e FM2 path is limited to a z. The FM2 path must be set
Phase modulation	62	le cutt	
Maximum deviation	\$OT	N x 80 radians	
	ent to	(N x 8 radians in high-l	pandwidth mode)
Resolution	ipri Jes	0.1% of set deviation	
Deviation accuracy	ase modulation ximum deviation N x 80 radians (N x 8 radians in high-bandwidth mode) solution 0.1% of set deviation /iation accuracy < ±5% of deviation + 0.01 radians (1 kHz rate, normal BW mode) dulation frequency response		
Modulation frequency r	esponse		,
Mode	,10.cc	Maximum Deviation	Rates (3 dB BW)
Normal BW	inth.	N x 80 rad	dc – 100 kHz
High BW		N x 8 rad	dc – 1 MHz (typ)
Mode Normal BW High BW Distortion		< 1 % (1 kHz rate, THD normal BW mode)	, dev < N x 80 rad,
Sensitivity		±1 Vpeak for indicated	deviation
Path		Φ M1 and Φ M2 are summed internally for composite modulation. Either path may be switched to any one of the modulation sources: Ext1, Ext2, internal1, internal2. The Φ M2 path must be set to a deviation less than Φ M1.	

¹² At the calibrated deviation and carrier frequency, within 5°C of ambient temperature at time of user calibration.

Amplitude modula	ntion (f _c > 2 MHz) ¹³ (typica	al)	
		Exponential (log) mode	
Depth	Linear mode	(Downward modulation only)	
Maximum	> 90%	> 20 dB	
Settable ¹⁴	0 - 100 %	0 to 40 dB	
Resolution	0.1%	0.01 dB	
Accuracy (1 kHz rate)	< ±(6 % of setting + 1 %)	$< \pm (2\% \text{ of setting} + 0.2 \text{ dB})$	
Ext sensitivity	±1 Vpeak for indicated depth	–1 V for indicated depth	
Rates (3 dB bandwidth	h, 30% depth)	dc/10 Hz to 100 kHz typical (useable to 1 MHz)	
Distortion (1 kHz rate,	linear mode, THD)		
30% AM		< 1.5%	
90% AM		< 4 %	
Path	IPME	AM1 and AM2 are summed internally for composite modulation. Either path may be switched to any one of the modulation sources: Ext1, Ext2, internal1, internal2.	
External modulation	on inputs (Ext1 & Ext2)	of Hid.	
Modulation types	50	AM, FM, and ΦM	
Input impedance	10, 10, 11	50 or 600 Ω, nominal, switched	
	I, ac coupled inputs only)	Activated when input level error exceeds 3%, nominal	
Simultaneous moo	dulation	All modulation types may be simultaneously enabled except: FM with Φ M, and linear AM with exponential AM. AM, FM, and Φ M can sum simultaneous inputs from any two sources (Ext1, Ext2, internal1, or internal2) Any given source (Ext1, Ext2, internal1, or internal2) may be routed to only one activated modulation type.	
Internal modulatio	on source	Dual function generators provides two independent signals (internal1 and internal2) for use with AM, FM, Φ M, or LF Out.	
Waveforms		Sine, square, positive ramp, negative ramp, triangle Gaussian noise, uniform noise, swept sine, dual sine ¹⁵	
Rate range			
Sine		0.5 Hz to 1 MHz	
Square, ramp, triangle		0.5 Hz to 100 kHz	
Resolution		0.5 Hz	
Accuracy		Same as timebase	

 $^{^{13}}$ For f c < 2 MHz AM is usable but not specified. AM specifications apply with ALC on, and envelope peaks < maximum specified power. For instruments without Option 1E1 attenuator, specs apply for carrier amplitude > $-2~{\rm dBm}.$

 $^{^{14}}$ For AM depth settings > 90% or > 20 dB, deep AM mode or 1 kHz ALC BW is recommended.

¹⁵ Internal2 is not available when using swept sine or dual sine modes.

LF out		
Output	Internal1 or internal2. Also provides monitoring of internal1 or internal2 when used for AM, FM, or $\Phi M.$	
Amplitude	0 to 3 Vpeak, nominal into 50 Ω	
Output impedance	50 Ω , nominal	
Swept sine mode: (frequency, phase continuous)		
Operating modes	Triggered or continuous sweeps	
Frequency range	1 Hz to 1 MHz	
Sweep rate	0.5 Hz to 100 k sweeps/s, equivalent to sweep times 10 us to 2 s	
Resolution	0.5 Hz (0.5 sweep/s)	
	1	
Pulse modulation		
	\geq 500 MHz to \leq 3.2 GHz ¹⁶ > 3.2 GHz	
Power range		

Pulse modulation		
	\geq 500 MHz to \leq 3.2 GHz ¹⁶	> 3.2 GHz
Power range		
Internally leveled	0 to +10 dBm	0 to +10 dBm
With option 1E1	-110 to +10 dBm	-110 to +10 dBm
On/off ratio	80 dB typical	80 dB
Rise/fall times (T _r , T _f)	100 ns typical	10 ns (6 ns typical)
Pulse width	and East	
Internally leveled	≥ 2 µs typical	≥ 1µs
ALC Off	≥ 0.5 µs typical	≥ 20 ns typical
Repetition freq		
Internally leveled	10 Hz to 250 kHz typical	10 Hz to 500 kHz typical
Internally leveled ALC Off Repetition freq Internally leveled ALC Off	dc to 1 MHz typical	dc to 10 MHz typical
Level accuracy (relative to CW)		
Internally leveled	±0.5 dB	±0.4 dB (±0.15 typical)
ALC Off with power search ¹⁷	±0.5 dB typical	≤ 20 GHz ±0.8 dB typical
71,00		≤ 40 GHz ±1.2 dB typical
Width compression	±50 ns typical	±5 ns typical
Video feedthrough ¹⁸	< 200 mV typical	< 2 mV typical
Pulse delay		
(ext input to RF output)	300 ns nominal	70 ns nominal

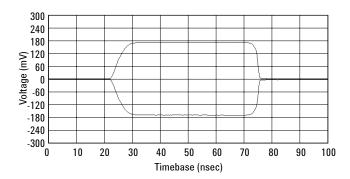
Pulse overshoot (V _{or})	< 10% typical
Input level	+1 Vpeak = RF On
Input impedance	50 Ω, nominal

 $^{^{16}}$ For improved performance \leq 3.2 GHz, special Option HE6 is available. Contact your local Agilent Online representative.

¹⁷ Power search is a calibration routine that improves level accuracy in ALC-off mode. Unpulsed RF power will be present typically up to 5 ms when executing power search

¹⁸ With attenuator in 0 dB position. Video feed-through decreases with attenuator setting.

Measured pulse modulation envelope



Internal pulse generator	
Modes	Free-run, triggered, triggered with delay, doublet, and gated. Triggered with delay, doublet, and gated require external trigger source.
Period (PRI) (T _p)	70 ns to 42 s (Repetition frequency: 0.024 Hz to 14.28 MHz)
Pulse width (T _w)	10 ns to 42 s
Delay (T _d)	or vo.
Free-run mode	0 to ±42 s
Triggered with delay and doublet mo	0 to ±42 s 75 ns to 42s with ±10 ns jitter
Resolution	10 ns (width, delay, and PRI)
RF delay (T _m) T _d Video delay (variable) T _w Video pulse width (variable) T _p Pulse period (variable)	< 20 ns typical Sync Output
Tp Pulse period (variable) Tm RF delay Trf RF pulse width Tf RF pulse fall time Tr RF pulse rise time Vor Pulse overshoot Vt Video feedthrough	Video Output T _W T _p
in.	RF Pulse 0 utput 0 0vor 0 0vf 0 0vor 0 0vf 0 0vf 0 0vor 0 0vo

L and A Series

Remote programming	
Interfaces	GPIB (IEEE-488.2,1987) with listen and talk, RS-232, and 10-base T-LAN interface.
Control languages	SCPI version 1992.0. Also will emulate most applicable Agilent 836xxB, Agilent 8373xB, and Agilent 8340/41B commands, providing general compatibility with ATE systems which include these signal generators.
IEEE-488 functions	SH1, AH1, T6, TE0, L4, LE0, SR1, RL1, PP0, DC1, DT0, C0, E2.
VXI <i>plug&play</i> drivers	Are available.

ISO compliant	This family of signal generators is manufactured in an ISO-9001 registered facility in concurrence with Agilent Technologies commitment to quality.
General	_
Power requirements	90 to 132 Vac 50 to 60 Hz, or 195 to 267 Vac 50 to 60 or 400 Hz, (automatically selected), 300 W maximum.
Operating temperature range	0 to 55°C
Storage temperature range	-40 to 71°C
Shock and vibration	Meets MIL-STD-28800E Type III, Class 3.
EMC	Conducted and radiated interference and immunity meets IEC/EN 61326-1 and MIL-STD-461C Part 2, RE02. Meets radiated emission requirements of CISPR Pub 11/1997 Group 1 class A.
Storage registers	Memory is shared by instrument states, user data files, sweep list files, and waveform sequences. Depending on the number and size of these files, up to 800 storage registers and 10 register sequences are available.
Security	Display blanking.
Compatibility	Agilent 83550 Series millimeter heads
Self-test Weight	Internal diagnostic routine tests most modules (including microcircuits) in a preset condition. For each module, if its node voltages are within acceptable limits, then module "passes" the test.
Weight	< 22 kg (48 lb.) net, < 30 kg (68 lb.) shipping.
Difference of the state of the	178 mm H x 426 mm W x 498 mm D (7" H x 16.8" W x 19.6" D in.).
Front panel connectors (All connectors are BNC female unless otherwise new panel of the second of th	oted.)
RF output	Nominal output impedance 50 Ω .
For 20 GHz models	Precision APC-3.5 male, or Type-N with Option 1ED
For 40 GHz models	Precision 2.4 mm male; plus 2.4-2.4 mm and 2.4-2.9 mm female adaptors also included.
ALC input	Used for negative external detector leveling. Nominal input impedance 120 k Ω , damage level ± 15 V.
LF output (PSG-A Series only)	Outputs the internally generated LF source. Nominal output impedance 50 Ω_{\cdot}
External input 1 (PSG—A Series only)	Drives either AM, FM, or $\Phi M.$ Nominal input impedance 50 or 600 $\Omega,$ damage levels are 5 Vrms and 10 Vpeak.
External input 2 (PSG-A Series only)	Drives either AM, FM, or Φ M. Nominal input impedance 50 or 600 Ω , damage levels are 5 Vrms and 10 Vpeak.
Pulse/trigger gate input (PSG-A Series only)	Accepts input signal for external fast pulse modulation. Also accepts external trigger pulse input for internal pulse modulation. Nominal impedance 50 Ω . Damage levels are 5 Vrms and 10 Vpeak.
Pulse video out (A series only)	Outputs a signal that follows the RF output in all pulse modes. TTL-level compatible, nominal source impedance 50 $\Omega_{\rm c}$

Pulse sync out (A series only)	Outputs a synchronizing pulse, nominally 50 ns width, during internal and triggered pulse modulation. TTL-level compatible, nominal source impedance 50 Ω .	
Rear panel connectors (All connectors are BNC female unless otherwise noted.)		
Serial interface	Used for serial communication (9-pin RS-232 connector female).	
GPIB	Allows communication with compatible devices.	
LAN	Allows LAN communication	
10 MHz input	Accepts an external reference (timebase) input (at 1, 2, 2.5, 5, 10 MHz for standard and 10 MHz only for option UNJ) Nominal input impedance 50 Ω . Damage levels > +10 dBm	
10 MHz output	Outputs internal or external reference signal. Nominal output impedance 50 Ω . Nominal output power +4 dBm	
Sweep output	Generates output voltage, 0 to +10 V when signal generator is sweeping. Output impedance < 1 Ω , can drive 2000 Ω .	
Trigger output	Outputs a TTL signal: high at start of dwell, or when waiting for point trigger in manual sweep mode; low when dwell is over or point trigger is received, high or low 4 us pulse at start of LF sweep.	
Trigger input	Accepts TTL signal for triggering point-to-point in manual sweep mode, or to trigger start of 1F sweep. Damage levels ≥ +10 V or ≤ .4 V.	
Source module interface	Provides bias, flatness correction, and leveling connections to the model 83550 Series mm-wave source modules.	
Source settled output	Provides an output trigger that indicates when the signal generator has settled to a new frequency or power level (open-collector output).	
EFC	> 0.25 ppm for -5 to +5 V	
Recommended calibration cycle	24 months	

Agilent Technologies' Test and Measurement Support, Services, and Assistance

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